# Shenzhen CTA Testing Technology Co., Ltd.



Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China

	TESTIN
	FCC PART 15.247
Report Reference No FCC ID	CTA24012400601 2AJJB-AT3
Compiled by ( position+printed name+signature) .:	File administrators Zoey Cao
Supervised by ( position+printed name+signature) .:	Project Engineer Amy Wen
Approved by ( position+printed name+signature) .:	RF Manager Eric Wang
Date of issue:	Jan. 26, 2024
Testing Laboratory Name:	Shenzhen CTA Testing Technology Co., Ltd.
Address:	Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Baoʻan District, Shenzhen, China
Applicant's name	
	SHENZHEN MAONO TECHNOLOGY CO., LTD
Address:	SHENZHEN MAONO TECHNOLOGY CO., LTD No. 1307, 13th Floor, Building 4, Phase II of Tianan Yungu Industrial Park, Gangtou Community, Bantian Street, Longgang District, Shenzhen, China
Address:	No. 1307, 13th Floor, Building 4, Phase II of Tianan Yungu Industrial Park, Gangtou Community, Bantian Street, Longgang District,
Address: Test specification: Standard	No. 1307, 13th Floor, Building 4, Phase II of Tianan Yungu Industrial Park, Gangtou Community, Bantian Street, Longgang District, Shenzhen, China FCC Part 15.247
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GAN CTA .	: OWS STATESTIN		
Equipment under Test	OWSCIA		
Model /Type	: AT3	CTA TEST	
Listed Models	: A131, A132, A133, A	T34, AT35, AT36, AT37, AT38	
Applicant	: SHENZHEN MAONO	TECHNOLOGY CO., LTD	
	TED		
Address		Building 4, Phase II of Tianan Yu	
	Shenzhen, China	unity, Bantian Street, Longgang I	Jistrict,
	G		District,
Manufacturer	: SHENZHEN MAONO	TECHNOLOGY CO., LTD	
Address	· No 1207 12th Elece	Ruilding 4. Phase II of Tiesen Ver	ngu Industrial
Address		Building 4, Phase II of Tianan Yu unity, Bantian Street, Longgang I	•
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	Shenzhen CTA Testing	Technology Co., Ltd.	
Room 106, Building 1, Yib	aolai Industrial Park, Qiaotou	<b>Technology Co., Ltd.</b> Community, Fuhai Street, Bao'an Dis	trict, Shenzhen, Cl
	aolai Industrial Park, Qiaotou	Technology Co., Ltd.	trict, Shenzhen, Cl

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6 PHOTOS OF THE EUT

# 1 TEST STANDARDS

The tests were performed according to following standards:

<u>FCC Rules Part 15.247</u>: Frequency Hopping, Direct Spread Spectrum and Hybrid Systems that are in operation within the bands of 902-928 MHz, 2400-2483.5 MHz, and 5725-5850 MHz. <u>ANSI C63.10-2013</u>: American National Standard for Testing Unlicensed Wireless Devices

#### SUMMARY 2

# 2.1 General Remarks

2.1 General Remarks		
Date of receipt of test sample		Jan. 20, 2024
Testing commenced on		Jan. 20, 2024
Testing concluded on	:	Jan. 26, 2024

# 2.2 Product Description

Testing commenced on	: Jan. 20, 2024	
Testing concluded on	: Jan. 26, 2024	
2.2 Product Descrip	otion	
Equipment under Test	OWS	
Model/Type reference:	AT3	
Power supply:	DC 3.7V From battery and DC 5.0V From external circuit	
Adapter information (Auxiliary test supplied by test Lab) :	Model: EP-TA20CBC Input: AC 100-240V 50/60Hz Output: DC 5V 2A	
Hardware version:	V1.0	
Software version:	V1.0	
Testing sample ID:	CTA240124006-1# (Engineer sample) CTA240124006-2# (Normal sample)	
Bluetooth :		
Supported Type:	Bluetooth BR/EDR	
Modulation:	GFSK, π/4DQPSK	
Operation frequency:	2402MHz~2480MHz	
Channel number:	79	
Channel separation:	1MHz	
Antenna type:	Chip antenna	
Antenna gain:	2.78 dBi	
	Testing concluded on <b>2.2 Product Descrip</b> Equipment under Test Model/Type reference: Power supply: Adapter information (Auxiliary test supplied by test Lab ) : Hardware version: Software version: Testing sample ID: <b>Bluetooth :</b> Supported Type: Modulation: Operation frequency: Channel number: Channel separation: Antenna type:	Testing concluded onIJan. 26, 2024 <b>3</b> Jan. 26, 2024 <b>2.2 Product Description</b> Equipment under TestOWSModel/Type reference:AT3Power supply:DC 3.7V From battery and DC 5.0V From external circuitAdapter information (Auxiliary test supplied by test Lab):Model: EP-TA20CBC Input: AC 100-240V 50/60Hz Output: DC 5 V 2AHardware version:V1.0Software version:V1.0Etuetooth :CTA240124006-1# (Engineer sample) CTA240124006-2# (Normal sample)Bluetooth :Bluetooth SR/EDRModulation:GFSK, $\pi/4$ DQPSKOperation frequency:2402MHz-2480MHzChannel number:79Channel separation:1MHzAntenna type:Chip arterna

# 2.3 Equipment Under Test

# Power supply system utilised

2.3 Equipment Under Test			TESTIN	16	6	
Power supply system utilised	k					
Power supply voltage	:	0	230V / 50 Hz	0	120V / 60Hz	
		0	12 V DC	Ο	24 V DC	
		•	Other (specified in blank belo	ow)		

DC 3.7V From battery and DC 5.0V From external circuit

#### Short description of the Equipment under Test (EUT) 2.4

This is a OWS.

For more details, refer to the user's manual of the EUT.

# 2.5 EUT operation mode

The Applicant provides communication tools software(Engineer mode) to control the EUT for staying in continuous transmitting (Duty Cycle more than 98%) and receiving mode for testing .There are 79 channels provided to the EUT and Channel 00/39/78 were selected to test.

Operation Frequency: Channel	Frequency (MHz)	
00	2402	
01	2403	
TING	÷	Constant of the
38	2440	
39	2441	
40	2442	
GA C.Y	ESTINE	
77	2479	
78	2480	
2.6 Block Diagram of Test Setup	CTAIL	

# 2.6 Block Diagram of Test Setup

EUT

DC 5.0V from adapter	

#### 2.7 Related Submittal(s) / Grant (s)

CTATE This submittal(s) (test report) is intended for the device filing to comply with Section 15.247 of the FCC Part 15, Subpart C Rules.

#### 2.8 Modifications

No modifications were implemented to meet testing criteria.

#### TEST ENVIRONMENT 3

#### Address of the test laboratory 3.1

### Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China

#### 3.2 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

#### FCC-Registration No.: 517856 Designation Number: CN1318

Shenzhen CTA Testing Technology Co., Ltd. has been listed on the US Federal Communications Commission list of test facilities recognized to perform electromagnetic emissions measurements.

Shenzhen CTA Testing Technology Co., Ltd. has been listed by American Association for Laboratory Accreditation to perform electromagnetic emission measurement

#### CAB identifier: CN0127 ISED#: 27890

Shenzhen CTA Testing Technology Co., Ltd. has been listed by Innovation, Science and Economic Development Canada to perform electromagnetic emission measurement.

The 3m-Semi anechoic test site fulfils CISPR 16-1-4 according to ANSI C63.10 and CISPR 16-1-4:2010.

### 3.3 Environmental conditions

GA CTATESTING During the measurement the environmental conditions were within the listed ranges:

Radiated Emission:

Temperature:	24 ° C
Humidity:	45 %
Atmospheric pressure:	950-1050mbar

#### AC Power Conducted Emission:

Temperature:	25 ° C	]
Llumiditur	46.9/	
Humidity:	46 %	STING
Atmospheric pressure:	950-1050mbar	ATES
Conducted testing:		
Temperature:	25 ° C	1

#### Conducted testina:

g	
Temperature:	25 ° C
Humidity:	44 %
Atmospheric pressure:	950-1050mbar
CTATESI	

# 3.4 Summary of measurement results

	Test Specification clause	Test case	Test Mode	Test Channel		orded eport	Test result
	§15.247(a)(1)	Carrier Frequency separation	GFSK Π/4DQPSK	⊠ Lowest ⊠ Middle ⊠ Highest	GFSK П/4DQPSK	Middle	Compliant
	§15.247(a)(1)	Number of Hopping channels	GFSK П/4DQPSK	S Full	GFSK	🛛 Full	Compliant
	§15.247(a)(1)	Time of Occupancy (dwell time)	GFSK П/4DQPSK	⊠ Lowest ⊠ Middle ⊠ Highest	GFSK П/4DQPSK	🛛 Middle	Compliant
CTATE	§15.247(a)(1)	Spectrumbandwidth of aFHSS system20dB bandwidth	GFSK II/4DQPSK	⊠ Lowest ⊠ Middle ⊠ Highest	GFSK ∏/4DQPSK	<ul><li>☑ Lowest</li><li>☑ Middle</li><li>☑ Highest</li></ul>	Compliant
	§15.247(b)(1)	Maximum output peak power	GFSK П/4DQPSK	<ul> <li>☑ Lowest</li> <li>☑ Middle</li> <li>☑ Highest</li> </ul>	GFSK ∏/4DQPSK	⊠ Lowest ⊠ Middle ⊠ Highest	Compliant
	§15.247(d)	Band edgecompliance conducted	GFSK Π/4DQPSK	<ul><li>☑ Lowest</li><li>☑ Highest</li></ul>	GFSK П/4DQPSK	⊠ Lowest ⊠ Highest	Compliant
(G	§15.205	Band edgecompliance radiated	GFSK П/4DQPSK	⊠ Lowest ⊠ Highest	GFSK П/4DQPSK	<ul><li>☑ Lowest</li><li>☑ Highest</li></ul>	Compliant
	§15.247(d)	TX spuriousemissions conducted	GFSK П/4DQPSK	⊠ Lowest ⊠ Middle ⊠ Highest	GFSK П/4DQPSK	⊠ Lowest ⊠ Middle ⊠ Highest	Compliant
	§15.247(d)	TX spuriousemissions radiated	GFSK Π/4DQPSK	Lowest Middle	GFSK	<ul> <li>☑ Lowest</li> <li>☑ Middle</li> <li>☑ Highest</li> </ul>	Compliant
	§15.209(a)	TX spurious Emissions radiated Below 1GHz	GFSK II/4DQPSK	⊠ Lowest ⊠ Middle ⊠ Highest	GFSK	Middle	Compliant
	§15.107(a) §15.207	Conducted Emissions 9KHz-30 MHz	GFSK ∏/4DQPSK	⊠ Lowest ⊠ Middle ⊠ Highest	GFSK	🛛 Middle	Compliant

#### Remark:

1. The measurement uncertainty is not included in the test result.

2. We tested all test mode and recorded worst case in report

## 3.5 Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to TR-100028-01" Electromagnetic compatibility and Radio spectrum Matters (ERM);Uncertainties in the measurement of mobile radio equipment characteristics; Part 1" and TR-100028-02 "Electromagnetic compatibility and Radio spectrum Matters (ERM);Uncertainties in the measurement characteristics; Part 2" and is documented in the Shenzhen CTA Testing Technology Co., Ltd. quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device. Hereafter the best measurement capability for Shenzhen CTA Testing Technology Co., Ltd. :

Test	Range	Measurement Uncertainty	Notes		
Radiated Emission	9KHz~30MHz	3.02 dB	(1)		
Radiated Emission	30~1000MHz	4.06 dB	(1)		
Radiated Emission	1~18GHz	5.14 dB	(1)		
Radiated Emission	18-40GHz	5.38 dB	(1)		
Conducted Disturbance	0.15~30MHz	2.14 dB	(1)		
Output Peak power	30MHz~18GHz	0.55 dB	(1)		
Power spectral density	/	0.57 dB	(1)		

Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China Tel:+86-755 2322 5875 E-mail:cta@cta-test.cn Web:http://www.cta-test.cn

Spectrum bandwidth	/	1.1%	(1)
Radiated spurious emission (30MHz-1GHz)	30~1000MHz	4.10 dB	(1)
Radiated spurious emission (1GHz-18GHz)	1~18GHz	4.32 dB	(1)
Radiated spurious emission (18GHz-40GHz)	18-40GHz	5.54 dB	(1)

(1) This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

# 3.6 Equipments Used during the Test

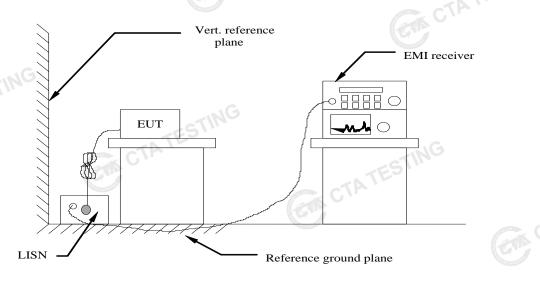
Test E	quipment	Manufacturer	Model No.	Equipment No.	Calibration Date	Calibration Due Date
L	ISN	R&S	ENV216	CTA-308	2023/08/02	2024/08/07
l	ISN CO	R&S	ENV216	CTA-314	2023/08/02	2024/08/07
EMI Te	st Receiver	R&S	ESPI	CTA-307	2023/08/02	2024/08/07
EMI Te	st Receiver	R&S	ESCI	CTA-306	2023/08/02	2024/08/07
Spectru	m Analyzer	Agilent	N9020A	CTA-301	2023/08/02	2024/08/01
Spectru	m Analyzer	G R&S	FSP	CTA-337	2023/08/02	2024/08/01
	or Signal nerator	Agilent	N5182A	CTA-305	2023/08/02	2024/08/01
	og Signal nerator	R&S	SML03	CTA-304	2023/08/02	2024/08/01
	ND RADIO JNICATION STER	CMW500	R&S	CTA-302	2023/08/02	2024/08/07
	rature and lity meter	Chigo	ZG-7020	CTA-326	2023/08/02	2024/08/07
Ultra-E	Broadband	Schwarzbeck	VULB9163	CTA-310	2023/10/17	2024/10/16
	Antenna	Schwarzbeck	BBHA 9120D	CTA-309	2023/10/13	2024/10/12
Loop	Antenna	Zhinan	ZN30900C	CTA-311	2023/10/17	2024/10/16
Horn	Antenna	Beijing Hangwei Dayang	OBH100400	CTA-336	2021/08/07	2024/08/06
An	nplifier	Schwarzbeck	BBV 9745	CTA-312	2023/08/02	2024/08/07
An	nplifier	Taiwan chengyi	EMC051845B	CTA-313	2023/08/02	2024/08/07
Directio	nal coupler	NARDA	4226-10	CTA-303	2023/08/02	2024/08/07
High-F	Pass Filter	SingBo	XBLBQ-GTA18	CTA-402	2023/08/02	2024/08/01
High-F	Pass Filter	XingBo	XBLBQ-GTA27	CTA-403	2023/08/02	2024/08/07
2 D TOTAL	ated filter bank	Tonscend	JS0806-F	CTA-404	2023/08/02	2024/08/07
Powe	r Sensor	Agilent	U2021XA	CTA-405	2023/08/02	2024/08/07
۸п	nplifier	Schwarzbeck	BBV9719	CTA-406	2023/08/02	2024/08/01

	Test Equipment	Manufacturer	Model No.	Version number	Calibration Date	Calibration Due Date	
	EMI Test Software	Tonscend	TS®JS32-RE	5.0.0.2	N/A	N/A	
	EMI Test Software	Tonscend	TS®JS32-CE	5.0.0.1	N/A	N/A	
	RF Test Software	Tonscend	TS®JS1120-3	3.1.65	N/A	N/A	
	RF Test Software	Tonscend	TS®JS1120	3.1.46	N/A	N/A	TATE
	TING					(CIA)	- <i>p</i>
CTATE	51	CTATESTING					
Ĩ		CTATES					

#### 4 TEST CONDITIONS AND RESULTS

#### AC Power Conducted Emission 4.1

# **TEST CONFIGURATION**



# **TEST PROCEDURE**

1 The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. The EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per ANSI C63.10-2013.

2 Support equipment, if needed, was placed as per ANSI C63.10-2013

3 All I/O cables were positioned to simulate typical actual usage as per ANSI C63.10-2013

4 The EUT received power from adapter, the adapter received AC120V/60Hz and AC 240V/60Hz power through a Line Impedance Stabilization Network (LISN) which supplied power source and was grounded to the ground plane.

5 All support equipments received AC power from a second LISN, if any.

6 The EUT test program was started. Emissions were measured on each current carrying line of the EUT using a spectrum Analyzer / Receiver connected to the LISN powering the EUT. The LISN has two monitoring points: Line 1 (Hot Side) and Line 2 (Neutral Side). Two scans were taken: one with Line 1 connected to Analyzer / Receiver and Line 2 connected to a 50 ohm load; the second scan had Line 1 connected to a 50 ohm load and Line 2 connected to the Analyzer / Receiver.

7 Analyzer / Receiver scanned from 150 KHz to 30MHz for emissions in each of the test modes.

8 During the above scans, the emissions were maximized by cable manipulation.

# AC Power Conducted Emission Limit

For intentional device, according to § 15.207(a) AC Power Conducted Emission Limits is as following :

Frequency range (MHz)	Limit	(dBuV)					
Frequency range (MHz)	Quasi-peak	Average					
0.15-0.5	66 to 56*	56 to 46*					
0.5-5	56	46					
5-30	60	50					

\* Decreases with the logarithm of the frequency

# TEST RESULTS

# Remark:

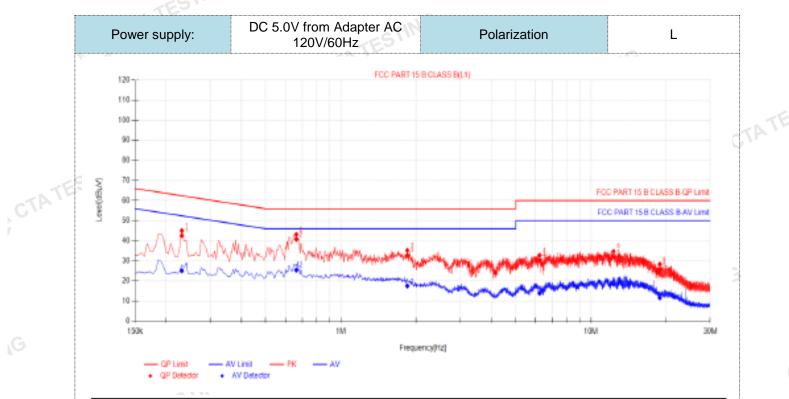
1. All modes of GFSK, II/4 DQPSK were test at Low, Middle, and High channel; only the worst result of GFSK Middle Channel was reported as below:

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2. Both 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz power supply have been tested, only the worst result of 120 VAC, 60 Hz was reported as below:



# Final Data Li

тпа												
NO.	Freq. (MHz)	Factor [dB]	QP Reading[dB µV]	QP Value [dBµV]	QP Limit [dBµV]	QP Margin [dB]	AV Reading [dBµV]	AV Value [dBµV]	AV Limit [dBµV]	AV Margin [dB]	Verdict	
1	0.231	10.00	32.53	42.53	62.41	19.88	15.11	25.11	52.41	27.30	PASS	
2	0.663	9.96	30.73	40.69	56.00	15.31	15.45	25.41	46.00	20.59	PASS	
3	1.842	9.92	22.79	32.71	56.00	23.29	7.58	17.50	46.00	28.50	PASS	
4	6.2295	10.18	20.21	30.39	60.00	29.61	3.69	13.87	50.00	36.13	PASS	
5	12.3225	10.28	21.60	31.88	60.00	28.12	7.94	18.22	50.00	31.78	PASS	
6	18.861	10.40	15.57	25.97	60.00	34.03	1.18	11.58	50.00	38.42	PASS	

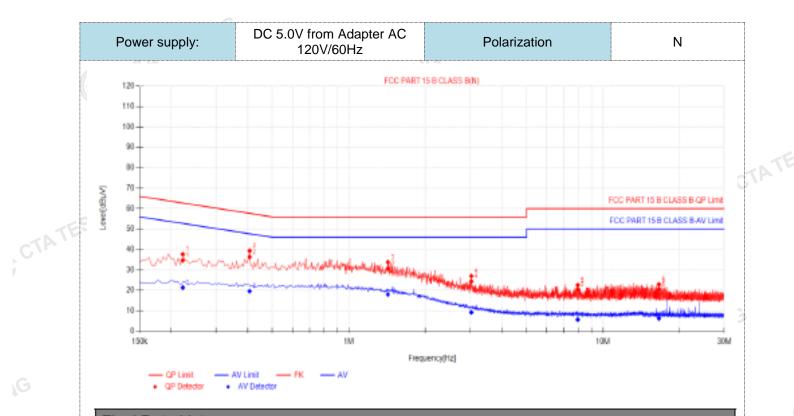
CTP CTP

Note:1).QP Value (dBµV)= QP Reading (dBµV)+ Factor (dB)

- 2). Factor (dB)=insertion loss of LISN (dB) + Cable loss (dB)
- 3). QPMargin(dB) = QP Limit (dB $\mu$ V) QP Value (dB $\mu$ V)
- TESTING 4). AVMargin(dB) = AV Limit (dB $\mu$ V) - AV Value (dB $\mu$ V)

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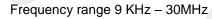
# Final Data List

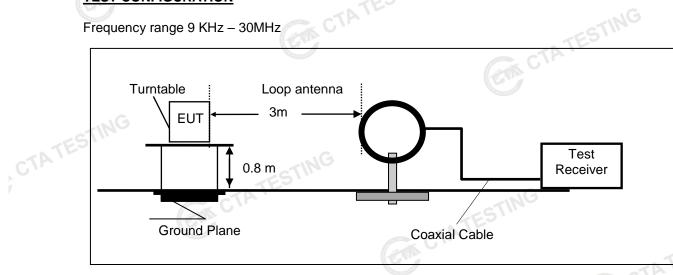
10.	Freq. [MHz]	Factor [dB]	QP Reading[dB µV]	QP Value [dBµV]	QP Limit [d8µV]	QP Margin [dB]	AV Reading [dBµV]	AV Value [dBµV]	AV Limit [dBµV]	AV Margin [dB]	Verdict
1	0.222	9.98	24.74	34.72	62.74	28.02	11.39	21.37	52.74	31.37	PASS
2	0.4065	9.94	26.46	36.40	57.72	21.32	9.67	19.61	47.72	28.11	PASS
3	1.4235	10.14	20.68	30.82	56.00	25.18	7.82	17.96	46.00	28.04	PASS
4	3.03	10.24	14.17	24.41	56.00	31.59	-1.01	9.23	46.00	36.77	PASS
5	7.962	10.42	9.98	20.40	60.00	39.60	-4.72	5.70	50.00	44.30	PASS
6	16.584	10.46	10.16	20.62	60.00	39.38	-4.08	6.38	50.00	43.62	PASS
e:1)	.QP Value	(dBuV)=	= OP Rea	adina (dF	3uV)+ Fa	ctor (dB)	)				

- 2). Factor (dB)=insertion loss of LISN (dB) + Cable loss (dB)
- 3). QPMargin(dB) = QP Limit (dBµV) QP Value (dBµV)
- CTA TESTING 4). AVMargin(dB) = AV Limit (dB $\mu$ V) - AV Value (dB $\mu$ V)

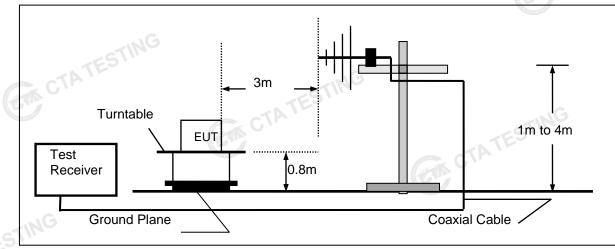
#### 4.2 **Radiated Emission**

# **TEST CONFIGURATION**

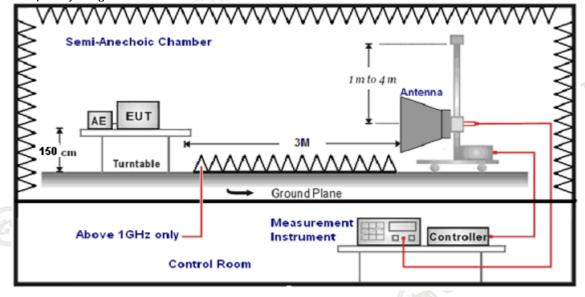




Frequency range 30MHz - 1000MHz



Frequency range above 1GHz-25GHz



6.

# TEST PROCEDURE

- 1. The EUT was placed on a turn table which is 0.8m above ground plane when testing frequency range 9 KHz -1GHz; the EUT was placed on a turn table which is 1.5m above ground plane when testing frequency range 1GHz - 25GHz.
- 2. Maximum procedure was performed by raising the receiving antenna from 1m to 4m and rotating the turn table from 0° to 360° to acquire the highest emissions from EUT.
- 3. And also, each emission was to be maximized by changing the polarization of receiving antenna both horizontal and vertical.
- Repeat above procedures until all frequency measurements have been completed. 4.
- Radiated emission test frequency band from 9KHz to 25GHz. 5.

The distance between test antenna and EUT as following table states:								
Т	est Frequency range	Test Distance						
9	KHz-30MHz	Active Loop Antenna	3					
3	0MHz-1GHz	Ultra-Broadband Antenna	3					
1	GHz-18GHz	Double Ridged Horn Antenna	3					
1	8GHz-25GHz	Horn Anternna	1					

Setting test receiver/spectrum as following table states: 7.

Setting test receiver/spectrum as following table states.							
Test Frequency range	Test Receiver/Spectrum Setting	Detector					
9KHz-150KHz	RBW=200Hz/VBW=3KHz,Sweep time=Auto	QP					
150KHz-30MHz	RBW=9KHz/VBW=100KHz,Sweep time=Auto	QP					
30MHz-1GHz	RBW=120KHz/VBW=1000KHz,Sweep time=Auto	QP					
	Peak Value: RBW=1MHz/VBW=3MHz,						
1GHz-40GHz	Sweep time=Auto	Peak					
IGHZ-40GHZ	Average Value: RBW=1MHz/VBW=10Hz,	геак					
	Sweep time=Auto						

# **Field Strength Calculation**

The field strength is calculated by adding the Antenna Factor and Cable Factor and subtracting the Amplifier Gain and Duty Cycle Correction Factor(if any) from the measured reading. The basic equation with a sample calculation is as follows:

# FS = RA + AF + CL - AG

sample calculation is as follows.	STINE
FS = RA + AF + CL - AG	CTATES
Where FS = Field Strength	CL = Cable Attenuation Factor (Cable Loss)
RA = Reading Amplitude	AG = Amplifier Gain
AF = Antenna Factor	

Transd=AF +CL-AG

# **RADIATION LIMIT**

For intentional device, according to § 15.209(a), the general requirement of field strength of radiated emission from intentional radiators at a distance of 3 meters shall not exceed the following table. According to § 15.247(d), in any 100kHz bandwidth outside the frequency band in which the EUT is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20dB below that in the100kHz bandwidth within the band that contains the highest level of desired power.

The pre-test have done for the EUT in three axes and found the worst emission at position shown in test setup photos.

Frequency (MHz)	Distance (Meters)	Radiated (dBµV/m)	Radiated (µV/m)
0.009-0.49	3	20log(2400/F(KHz))+40log(300/3)	2400/F(KHz)
0.49-1.705	3	20log(24000/F(KHz))+ 40log(30/3)	24000/F(KHz)
1.705-30	3	20log(30)+ 40log(30/3)	30
30-88	3	40.0	100
88-216	3	43.5	150
216-960	3	46.0	200
Above 960	3	54.0	500

### Report No.: CTA24012400601

TATE

TESTING

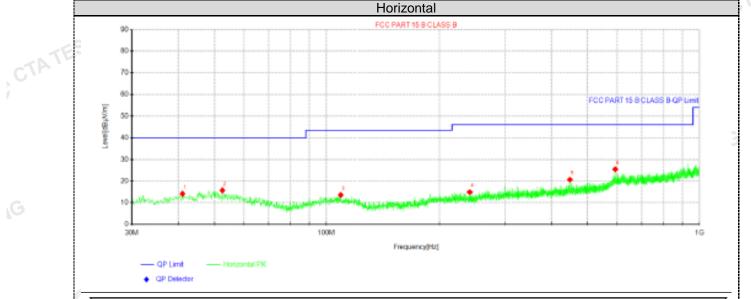
CTA

# TEST RESULTS

Remark:

- This test was performed with EUT in X, Y, Z position and the worse case was found when EUT in X 1. position.
- 2. We measured Radiated Emission at GFSK, π/4 DQPSK mode from 9 KHz to 25GHz and recorded worst case at GFSK DH5 mode.
- For below 1GHz testing recorded worst at GFSK DH5 middle channel. 3.
- Radiated emission test from 9 KHz to 10th harmonic of fundamental was verified, and no emission found 4. except system noise floor in 9 KHz to 30MHz and not recorded in this report.

# For 30MHz-1GHz



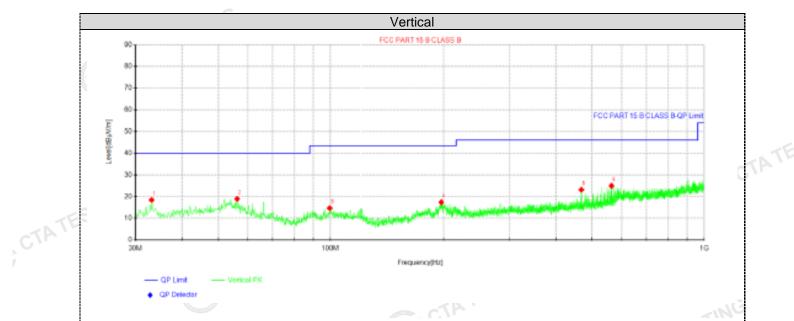
# Suspected Data Li

CTATE

Janaho											
NO.	Freq. [MHz]	Reading [dBµV]	Level [dBµV/m]	Factor [dB/m]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity		
1	41.0338	26.27	14.14	-12.13	40.00	25.86	100	240	Horizontal		
2	52.5525	27.39	15.70	-11.69	40.00	24.30	100	110	Horizontal		
3	109.297	27.24	13.59	-13.65	43.50	29.91	100	280	Horizontal		
4	241.096	27.75	14.89	-12.86	46.00	31.11	100	80	Horizontal		
5	448.07	30.69	20.69	-10.00	46.00	25.31	100	150	Horizontal		
6	593.448	31.15	25.43	-5.72	46.00	20.57	100	360	Horizontal		

Note:1).Level ( $dB\mu V/m$ )= Reading ( $dB\mu V$ )+ Factor (dB/m)

- 2). Factor(dB/m)=Antenna Factor (dB/m) + Cable loss (dB) Pre Amplifier gain (dB)
- 3). Margin(dB) = Limit (dB $\mu$ V/m) Level (dB $\mu$ V/m)



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CTATE

Suspe	Suspected Data List										
NO	Freq.	Reading	Level	Factor	Limit	Margin	Height	Angle	Delecity		
NO.	[MHz]	[dBµV]	[dBµV/m]	[dB/m]	[dBµV/m]	[dB]	[cm]	[°]	Polarity		
1	33.1525	32.62	18.42	-14.20	40.00	21.58	100	290	Vertical		
2	56.19	31.18	18.94	-12.24	40.00	21.06	100	130	Vertical		
3	99.5975	28.06	14.63	-13.43	43.50	28.87	100	340	Vertical		
4	196.961	30.88	17.37	-13.51	43.50	26.13	100	40	Vertical		
5	467.955	32.92	23.14	-9.78	46.00	22.86	100	0	Vertical		
6	563.863	32.66	24.93	-7.73	46.00	21.07	100	150	Vertical		

Note:1).Level (dBµV/m)= Reading (dBµV)+ Factor (dB/m)

2). Factor(dB/m)=Antenna Factor (dB/m) + Cable loss (dB) - Pre Amplifier gain (dB)

3). Margin(dB) = Limit (dB $\mu$ V/m) - Level (dB $\mu$ V/m)

### For 1GHz to 25GHz

Note: GFSK ,  $\pi/4$  DQPSK all have been tested, only worse case GFSK is reported. GFSK (above 1GHz)

Freque	Frequency(MHz):			2402		Polarity:		HORIZONTAL			
Frequency (MHz)	Le	ssion vel V/m)	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)		
4804.00	60.55	PK	74	13.45	64.82	32.33	5.12	41.72	-4.27		
4804.00	44.39	AV	54	9.61	48.66	32.33	5.12	41.72	-4.27		
7206.00	53.72	PK	74	20.28	54.24	36.6	6.49	43.61	-0.52		
7206.00	41.61	AV	54	12.39	42.13	36.6	6.49	43.61	-0.52		

									G	
Freque	Frequency(MHz):			2402		Polarity:		VERTICAL		
Frequency (MHz)	-	sion vel V/m)	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)	
4804.00	58.47	PK	74	15.53	62.74	32.33	5.12	41.72	-4.27	
4804.00	42.49	AV	54	11.51	46.76	32.33	5.12	41.72	-4.27	
7206.00	50.52	PK	74	23.48	51.04	36.6	6.49	43.61	-0.52	
7206.00	41.03	AV	54	12.97	41.55	36.6	6.49	43.61	-0.52	

Freque	Frequency(MHz):			2441		Polarity:		HORIZONTAL		
Frequency (MHz)	Emis Lev (dBu)	/el	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)	
4882.00	60.26	PK	74	13.74	64.14	32.6	5.34	41.82	-3.88	
4882.00	44.09	AV	54	9.91	647.97	32.6	5.34	41.82	-3.88	
7323.00	52.67	PK	74	21.33	52.78	36.8	6.81	43.72	-0.11	
7323.00	41.61	AV	54	12.39	41.72	36.8	6.81	343.72	-0.11	
	G V						STIN			

Frequency(MHz):			2441		Polarity:		VERTICAL		
Frequency (MHz)	Emis Lev (dBu)	vel	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
4882.00	57.93	PK	74	16.07	61.81	32.6	5.34	41.82	-3.88
4882.00	43.35	AV	54	10.65	47.23	32.6	5.34	41.82	-3.88
7323.00	51.72	PK	74	22.28	51.83	36.8	6.81	43.72	-0.11
7323.00	40.96	AV	54	13.04	41.07	36.8	6.81	43.72	-0.11
			ES						

Frequency(MHz):			2480		Polarity:		HORIZONTAL		
Frequency (MHz)	Emis Lev (dBu)	vel	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
4960.00	59.74	PK	74	14.26	62.82	32.73	5.66	41.47	-3.08
4960.00	45.48	AV	54	8.52	48.56	32.73	5.66	41.47	-3.08
7440.00	53.56	PK	74	20.44	53.11	37.04	7.25	43.84	0.45
7440.00	42.03	PK	54	11.97	41.58	37.04	7.25	43.84	0.45

Frequency(MHz):			2480		Polarity:		VERTICAL		
Frequency (MHz)	Emis Lev (dBu)	vel	Limit (dBuV/m)	Margin (dB)	G Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
4960.00	58.57	PK	74 G	15.43	61.65	32.73	5.66	41.47	-3.08
4960.00	42.73	AV	54	11.27	45.81	32.73	5.66	41.47	-3.08
7440.00	51.65	PK	74	22.35	51.20	37.04	7.25	43.84	0.45
7440.00	41.35	PK	54	12.65	40.90	37.04	7.25	43.84	0.45
REMARKS	:		· · ·			A DECEMBER OF THE PARTY OF THE			CTP
			Shenzhen	CTA Testing	Technology	Co., Ltd.			

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- 1. Emission level (dBuV/m) =Raw Value (dBuV)+Correction Factor (dB/m)
- 2. Correction Factor (dB/m) = Antenna Factor (dB/m)+Cable Factor (dB)- Pre-amplifier
- 3. Margin value = Limit value- Emission level.
- 4. -- Mean the PK detector measured value is below average limit.
- 5. The other emission levels were very low against the limit.

# Results of Band Edges Test (Radiated)

Note: GFSK,  $\pi/4$  DQPSK all have been tested, only worse case GFSK is reported. CECK

	Freque	ncy(MHz)	):	24	02	Pola	arity:	F	IORIZONTA	AL .
	Frequency (MHz)	Le	ssion vel V/m)	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
<p< td=""><td>2390.00</td><td>60.90</td><td>PK</td><td>74 G</td><td>13.10</td><td>71.32</td><td>27.42</td><td>4.31</td><td>42.15</td><td>-10.42</td></p<>	2390.00	60.90	PK	74 G	13.10	71.32	27.42	4.31	42.15	-10.42
	2390.00	42.74	AV	54	11.26	53.16	27.42	4.31	42.15	-10.42
	Freque	ncy(MHz)	):	24	02	Pola	arity:		VERTICAL	
	Frequency (MHz)	Emis Le <sup>v</sup> (dBu		Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correctio Factor (dB/m)
	2390.00	59.26	PK	74	14.74	69.68	27.42	4.31	42.15	-10.42
	2390.00	41.43	AV	54	12.57	51.85	27.42	4.31	42.15	-10.42
	Freque	ncy(MHz)	):	24	80	Pola	arity:	F	IORIZONT	AL.
	Frequency (MHz)		ssion vel V/m)	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correctio Factor (dB/m)
	2483.50	60.43	PK	74	13.57	70.54	27.7	4.47	42.28	-10.11
	2483.50	42.55	AV	54	11.45	52.66	27.7	4.47	42.28	-10.11
	Freque	ncy(MHz)	):	24	80	Pola	arity:		VERTICAL	
	Frequency (MHz)	Emis Le <sup>s</sup> (dBu	vel	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
			PK	74	15.48	68.63	27.7	4.47	42.28	-10.11
	2483.50	58.52	ΓN							

2. Correction Factor (dB/m) = Antenna Factor (dB/m)+Cable Factor (dB)- Pre-amplifier

3. Margin value = Limit value- Emission level.

4. -- Mean the PK detector measured value is below average limit.

GA CTATESTING 5. The other emission levels were very low against the limit.

#### **Maximum Peak Output Power** 4.3

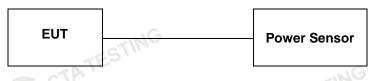
# Limit

The Maximum Peak Output Power Measurement is 125mW (20.97).

# Test Procedure

Remove the antenna from the EUT and then connect a low loss RF cable from the antenna port to CTATE the powersensor.

# **Test Configuration** CTATESTING



# Test Results

Туре	Channel	Output power (dBm)	Limit (dBm)	Result
	00	-1.84	R	TES
GFSK	39	-1.23	20.97	Pass
	78	-0.46		
	G 00	-0.95		
π/4DQPSK	39	-0.38	20.97	Pass
CTA	78	0.42		
Note: 1.The test res	ults including the	cable lose.	ESTING	·
			CTATESTING	

#### 20dB Bandwidth 4.4

# Limit

For frequency hopping systems operating in the 2400MHz-2483.5MHz no limit for 20dB bandwidth.

# **Test Procedure**

The transmitter output was connected to the spectrum analyzer through an attenuator. The bandwidth of the fundamental frequency was measured by spectrum analyzer with 30 KHz RBW and 100 KHz VBW.

The 20dB bandwidth is defined as the total spectrum the power of which is higher than peak power minus 20dB.

# **Test Configuration**



# Test Results

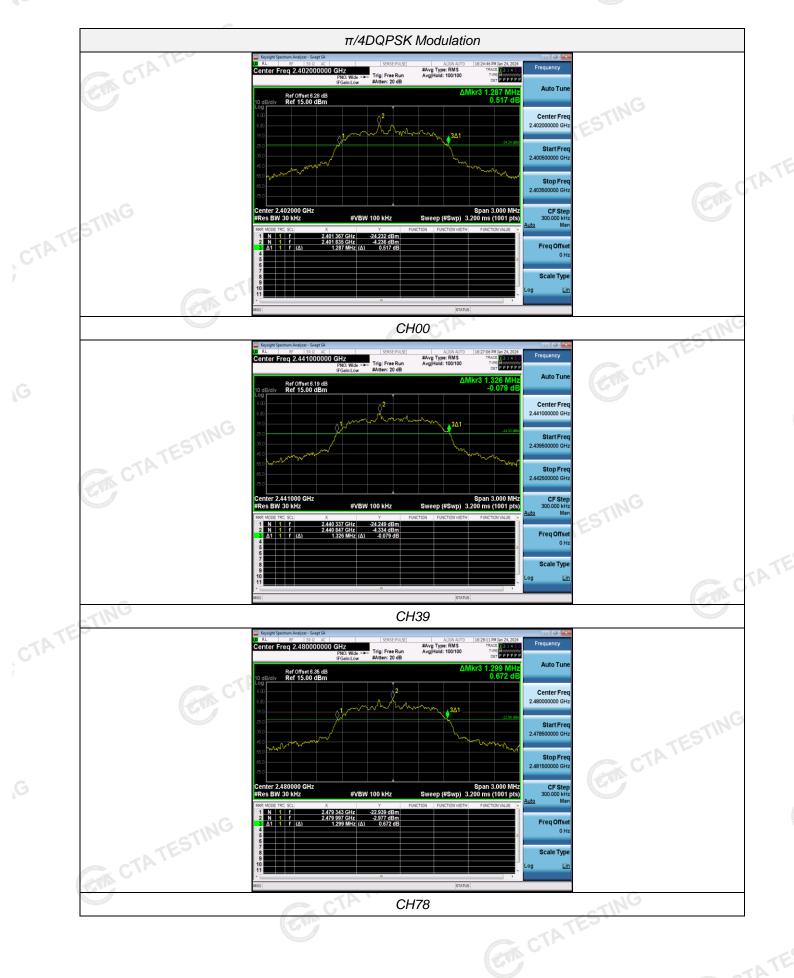
<u>st Results</u>			CTA TESTING
Modulation	Channel	20dB bandwidth (MHz)	Result
TING	CH00	1.002	
GFSK	CH39	0.999	1
CTA	CH78	0.993	
	CH00	1.287	- Pass
π/4DQPSK	CH39	1.326	STING
Γ	CH78	1.299	1
		G	CT CT
est plot as follows:			CAC'

# Test plot as follows: CTATES









# 4.5 Frequency Separation

# LIMIT

According to 15.247(a)(1), frequency hopping systems shall have hopping channel carrier frequencies separated by minimum of 25KHz or the 2/3\*20dB bandwidth of the hopping channel, whichever is greater.

### **TEST PROCEDURE**

The transmitter output was connected to the spectrum analyzer through an attenuator. The bandwidth of the fundamental frequency was measured by spectrum analyzer with100 KHz RBW and 300 KHz VBW.

# **TEST CONFIGURATION**



### TEST RESULTS

TEST RESULTS				TATESTING
Modulation	Channe	Channel Separati (MHz)	ion Limit(MHz)	Result
GFSK	CH38	0.984	25KHz or 2/3*20dB	Pass
GFSK	CH39	0.904	bandwidth	r dss
π/4DQPSK	CH38	1.184	25KHz or 2/3*20dB	Page
11/4DQF3K	CH39	TES1.104	bandwidth	Pass

### Note:

We have tested all mode at high, middle and low channel, and recorded worst case at middle

### Test plot as follows:



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#### Number of hopping frequency 4.6

# Limit C

Frequency hopping systems in the 2400–2483.5 MHz band shall use at least 15 channels.

### **Test Procedure**

GTA CTATE The transmitter output was connected to the spectrum analyzer through an attenuator. Set spectrum analyzer start 2400MHz to 2483.5MHz with 100 KHz RBW and 300 KHz VBW.

# **Test Configuration** CTATES



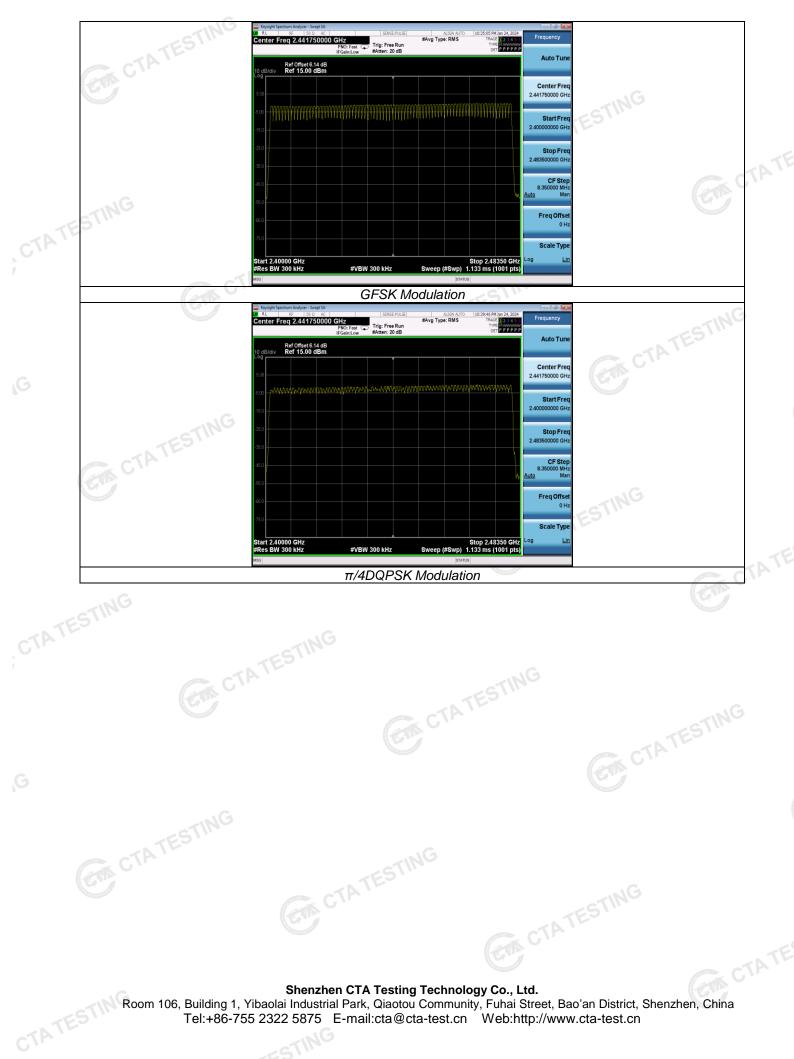
## **Test Results**

Test Results	CTAT	CTATE				
Modulation	Number of Hopping Channel	Limit	Result			
GFSK	79	≥15	Pass			
π/4DQPSK	79	215	Fass			

# Test plot as follows: CTATES



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# 4.7 Time of Occupancy (Dwell Time)

# Limit

The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed.

# Test Procedure

The transmitter output was connected to the spectrum analyzer through an attenuator. Set center frequency of spectrum analyzer=operating frequency with 1MHz RBW and 1MHz VBW, Span 0Hz.

## **Test Configuration**



Test Results

		6	1		-NTES
Modulation	Packet	Burst time (ms)	Dwell time (s)	Limit (s)	Result
	DH1	0.36	0.115	Contract of the second s	
GFSK	GDH3	1.62	0.259	0.40	Pass
TES	DH5	2.87	0.306		
Cir	2-DH1	0.38	0.122		
π/4DQPSK	2-DH3	1.63	0.261	0.40	Pass
	2-DH5	2.87	0.306	TESTIN	

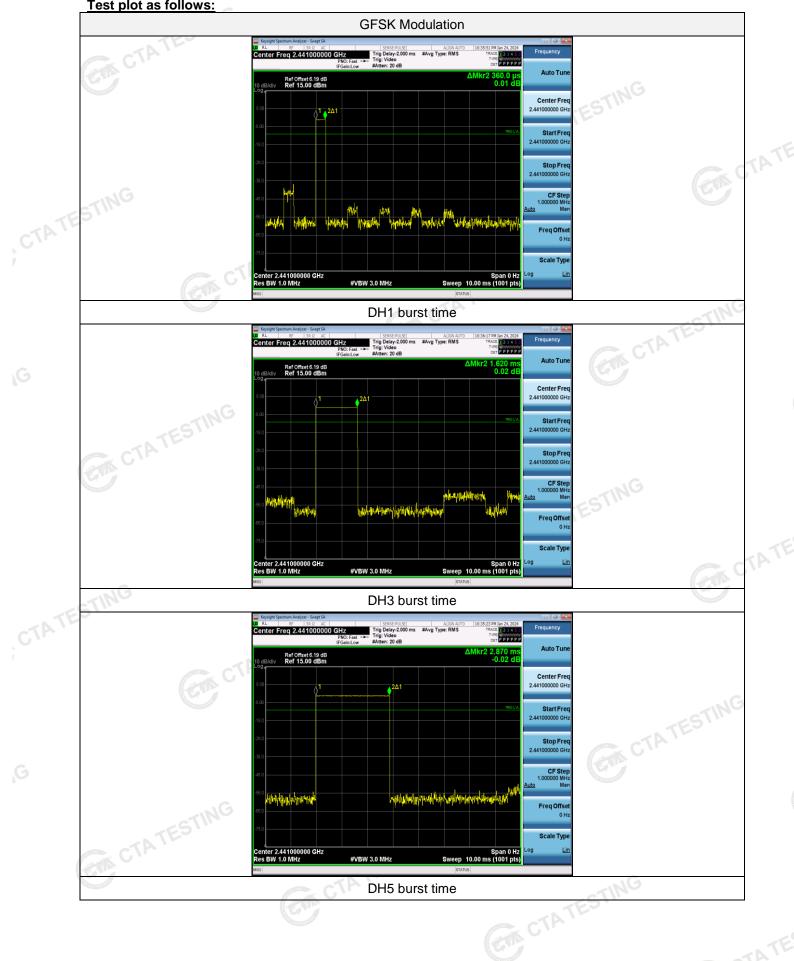
Note:We have tested all mode at high, middle and low channel, and recoreded worst case at middle channel.

Dwell time=Pulse time (ms) ×  $(1600 \div 2 \div 79)$  ×31.6 Second for DH1, 2-DH1 Dwell time=Pulse time (ms) ×  $(1600 \div 4 \div 79)$  ×31.6 Second for DH3, 2-DH3 Dwell time=Pulse time (ms) ×  $(1600 \div 6 \div 79)$  ×31.6 Second for DH5, 2-DH5

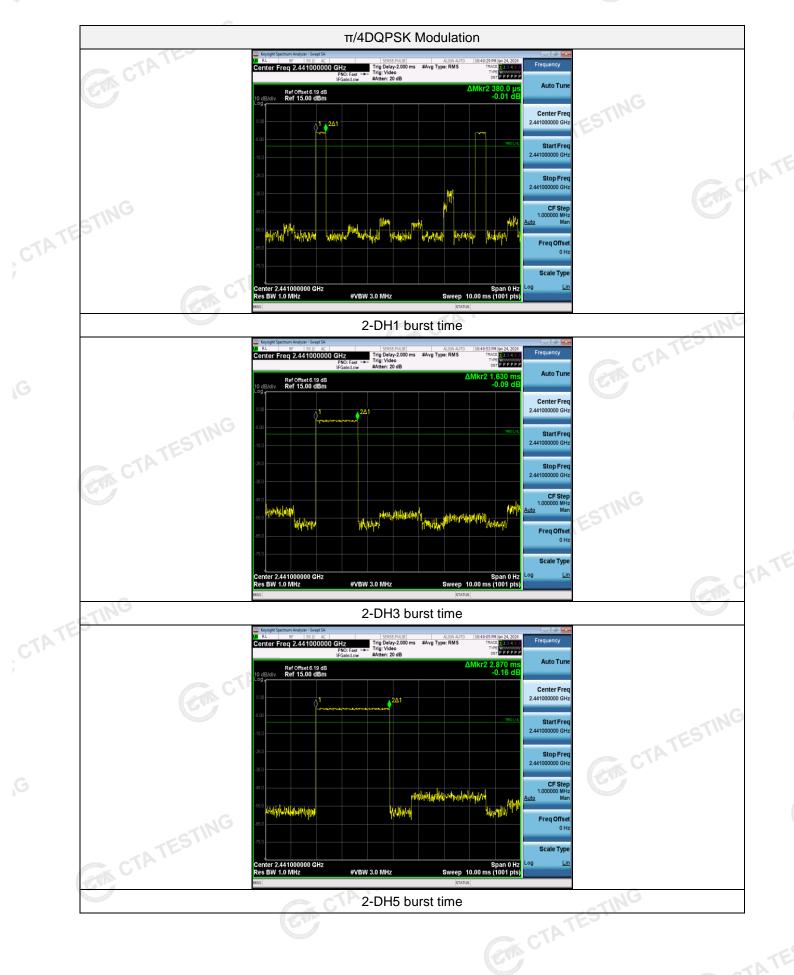
CTA TESTING

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# Test plot as follows:



### Report No.: CTA24012400601



#### **Out-of-band Emissions** 4.8

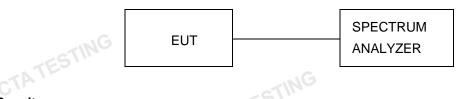
### Limit

In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, pro-vided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter com-plies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in §15.209(a) is not required.

### **Test Procedure**

Connect the transmitter output to spectrum analyzer using a low loss RF cable, and set the spectrum analyzer to RBW=100 kHz, VBW= 300 kHz, peak detector , and max hold. Measurements utilizing these setting are CTATES made of the in-band reference level, bandedge and out-of-band emissions.

### **Test Configuration**



# **Test Results**

Remark: The measurement frequency range is from 30MHz to the 10th harmonic of the fundamental frequency. The lowest, middle and highest channels are tested to verify the spurious emissions and bandage measurement data.

We measured all conditions (DH1, DH3, DH5) and recorded worst case at DH5

Test plot as follows: .. ph

